

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/816,378	LEE, CHUNG-CHIEH	
Examiner		Art Unit		Page 1 of 1
Wutchung Chu		2619		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0136200	09-2002	St. John, James T.	370/352
*	B	US-6,047,309	04-2000	Dan et al.	709/201
*	C	US-2001/0053152	12-2001	Sala et al.	370/412
*	D	US-2003/0128707	07-2003	Kalkunte et al.	370/395.41
*	E	US-6,198,724	03-2001	Lam et al.	370/233
*	F	US-7,177,274	02-2007	Van Der Zee et al.	370/230
*	G	US-6,563,829	05-2003	Lyles et al.	370/395.21
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.